

# Rochester Electronics Manufactured Components

Rochester branded components are manufactured using either die/wafers purchased from the original suppliers or Rochester wafers recreated from the original IP. All recreations are done with the approval of the OCM.

Parts are tested using original factory test programs or Rochester developed test solutions to guarantee product meets or exceed the OCM data sheet.

### **Quality Overview**

- ISO-9001
- AS9120 certification
- Qualified Manufacturers List (QML) MIL-PRF-35835
  - Class Q Military
  - Class V Space Level
- Qualified Suppliers List of Distributors (QSLD)
- Rochester is a critical supplier to DLA and meets all industry and DLA standards.

Rochester Electronics, LLC is committed to supplying products that satisfy customer expectations for quality and are equal to those originally supplied by industry manufacturers.

The original manufacturer's datasheet accompanying this document reflects the performance and specifications of the Rochester manufactured version of this device. Rochester Electronics guarantees the performance of its semiconductor products to the original OEM specifications. 'Typical' values are for reference purposes only. Certain minimum or maximum ratings may be based on product characterization, design, simulation, or sample testing.

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- D-Type Flip-Flops in a Single Package With 3-State Bus-Driving True Outputs
- Full Parallel Access for Loading
- Buffered Control Inputs
- Package Options Include Plastic Small-Outline (DW) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

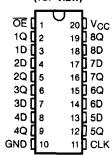
#### description

These octal D-type edge-triggered flip-flops feature 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. They are particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

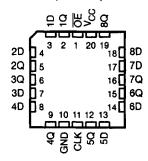
On the positive transition of the clock (CLK) input, the Q outputs are set to the logic levels set up at the data (D) inputs.

A buffered output-enable ( $\overline{OE}$ ) input places the eight outputs in either a normal logic state (high or low logic levels) or a high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and the increased drive provide the capability to drive bus lines without interface or pullup components.

SN54ALS374, SN54AS374 . . . J PACKAGE SN74ALS374A, SN74AS374 . . . DW OR N PACKAGE (TOP VIEW)



SN54ALS374, SN54AS374...FK PACKAGE (TOP VIEW)



OE does not affect internal operations of the flip-flops. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

The SN54ALS374 and SN54AS374 are characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ALS374A and SN74AS374 are characterized for operation from 0°C to 70°C.

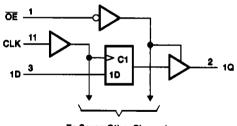
# FUNCTION TABLE (each flip-flop)

	INPUTS		OUTPUT
ŌĒ	CLK	D	<u> </u>
L	1	Н	Н
L	Ť	L	L
L	L	X	Q <sub>0</sub>
Η	X	_ X	Z

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#### logic symbol<sup>†</sup> ΕN > C1 7 1D 10 10 5 2D 2Q 3D 3Q 8 9 4D 4Q 12 13 5D 5Q 15 14 8D 60 17 16

#### logic diagram (positive logic)



To Seven Other Channels

7D

٩D

18

# absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

70

80

19

Supply voltage, V <sub>CC</sub>	7 V
Input voltage, V <sub>I</sub>	7 V
Voltage applied to a disabled 3-state output	5.5 V
Operating free-air temperature range, TA: SN54ALS374	55°C to 125°C
SN74ALS374A	0°C to 70°C
Storage temperature range	-65°C to 150°C

<sup>\$</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### recommended operating conditions

		SN	54AL83	74	SN74ALS374A			
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
ViH	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.7			0.8	V
Юн	High-level output current			-1		_	-2.6	mA
lor	Low-level output current			12			24	mA
<sup>f</sup> clock	Clock frequency	0		30	0		35	MHz
tw	Pulse duration, CLK high or low	16.5			14			ns
tsu	Setup time, data before CLK↑	10			10			ns
th	Hold time, data after CLKT	4	_		0	_		ns
TA	Operating free-air temperature	-55		125	0		70	*C

<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

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# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

D. D	TEST CONDITIONS		SN54ALS374			SN74ALS374A			
PARAMETER			MIN	TYPT	MAX	MIN	TYP	MAX	UNIT
VIK	V <sub>CC</sub> = 4.5 V,	lj = -18 mA			- 1.5			-1.5	٧
	V <sub>CC</sub> = 4.5 V to 5.5 V,	lOH = -0.4 mA	V <sub>CC</sub> -2	2		Vcc -	2		
VOH	V== 45V	IOH = -1 mA	2.4	3.3					٧
_	V <sub>CC</sub> = 4.5 V	IOH = -2.6 mA				2.4	3.2		
Mari	V <sub>CC</sub> = 4.5 V	IOL = 12 mA		0.25	0.4		0.25	0.4	v
VOL		IOL = 24 mA					0.35	0.5	V
lozh	V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 2.7 V			20			20	μА
<sup>I</sup> OZL	V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 0.4 V			-20			-20	μА
lj .	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 7 V			0.1			0.1	mA
ΊΗ	V <sub>CC</sub> = 5.5 V,	V <sub>1</sub> = 2.7 V			20			20	μА
IIL.	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 0.4 V			-0.2			-0.2	mA
10 <sup>‡</sup>	V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 2.25 V	-20		-112	-30		-112	mA
		Outputs high		11	19		11	19	
Icc	V <sub>CC</sub> = 5.5 V	Outputs low		19	28		19	28	mA
-		Outputs disabled		20	31		20	31	

<sup>†</sup> All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C.

#### switching characteristics (see Figure 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	C <sub>L</sub> R1	V <sub>CC</sub> = 4.5 V to 5.5 V, C <sub>L</sub> = 50 pF, R1 = 500 Ω, R2 = 500 Ω, T <sub>A</sub> = MIN to MAX <sup>§</sup>					
			SN54AI	.S374	SN74AL				
			MIN	MAX	MIN	MAX			
fmax			30		35		MHz		
tPLH	CLK	Q	3	14	3	12	ns		
tPHL	CLK		5	17	5	16	l ns		
<sup>t</sup> PZH	ŌĒ	٥	5_	18	3	17	ns		
<sup>t</sup> PZL	OE	٩	6	21	5	18	115		
tPHZ	ŌĒ	a	2	11	1	10			
tPLZ	OE	L	3	19	2	18	ns		

<sup>§</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

# SN54ALS374, SN54AS374, SN74ALS374A, SN74AS374 OCTAL D-TYPE EDGE-TRIGGERED FLIP-FLOPS WITH 3-STATE OUTPUTS SDAS167A - APRIL 1982 - REVISED DECEMBER 1994

# absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V <sub>CC</sub>	
Input voltage, V <sub>I</sub>	7 V
Voltage applied to a disabled 3-state output	5.5 V
Operating free-air temperature range, T <sub>A</sub> : SN54AS374	55°C to 125°C
SN74AS374	0°C to 70°C
Storage temperature range	65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### recommended operating conditions

	•		81	N54AS37	74	SN74AS374			11547
				MAX	MIN	NOM	MAX	UNIT	
Vcc	Supply voltage		4.5	5	5.5	4.5	5	5.5	٧
VIH	High-level input voltage		2			2			٧
V <sub>IL</sub>	Low-level input voltage				0.7			0.8	٧
ЮН	High-level output current				-12		_	-15	mA
loL	Low-level output current				32			48	mA
<sup>1</sup> clock	Clock frequency		0		100	0		125	MHz
tw*	Pulse duration	CLK high	5.5			4			
.w	- uise udiation	CLK low	3			3			ns
t <sub>su</sub> *	Setup time, data before CLK↑		3			2			nŝ
th*	Hold time, data after CLK↑		3			2			ns
TA	Operating free-air temperature		-55		125	0		70	°C

On products compliant to MIL-STD-883, Class B, this parameter is based on characterization data but is not production tested.



# SN54ALS374, SN54AS374, SN74ALS374A, SN74AS374 OCTAL D-TYPE EDGE-TRIGGERED FLIP-FLOPS WITH 3-STATE OUTPUTS SDAS167A - APRIL 1982 - REVISED DECEMBER 1994

#### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED		TEST CONDITIONS		AS .	154AS37	74	18				
М	ARAMETER	IESI C	ONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	UNIT	
ViK		V <sub>CC</sub> = 4.5 V,	lj = -18 mA			~1.2			-1.2	٧	
		V <sub>CC</sub> = 4.5 V to 5.5 V,	IOH = -2 mA	V <sub>CC</sub> -2	!		VCC -2	?			
Vон		V== 45V	IOH = -12 mA	2.4	3.2					٧	
		V <sub>CC</sub> = 4.5 V	IOH = -15 mA				2.4	3.3			
V <sub>OL</sub>		V 45V	IOL = 32 mA		0.29	0.5					
		V <sub>CC</sub> = 4.5 V	I <sub>OL</sub> = 48 mA					0.34	0.5	l *	
lozн		V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 2.7 V			50			50	μА	
OZL		V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 0.4 V			-50			-50	μА	
lį		V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 7 V			0.1			0.1	mA	
lн		V <sub>CC</sub> = 5.5 V,	V <sub>1</sub> = 2.7 V			20			20	μΑ	
	OE, CLK	V <sub>CC</sub> = 5.5 V,	14. 0.414			-0.5			-0.5		
ll.	Data		V <sub>I</sub> = 0.4 V			-3			-2	mA	
10 <sup>‡</sup>		V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 2.25 V	-30		-112	-30		-112	mA	
			Outputs high		77	120		77	120		
lcc		V <sub>CC</sub> = 5.5 V	Outputs low		84	128		84	128	mA.	
			Outputs disabled		84	128	<u> </u>	84	128		

<sup>†</sup> All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C.

#### switching characteristics (see Figure 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	VC CL R1 R2 TA	UNIT			
			SN54A	8374	SN74AS374		İ
			MIN	MAX	MIN	MAX	
fmax*			100		125		MHz
t <sub>PLH</sub>	CLK	Q	3	11	3	8	ns
<sup>t</sup> PHL	OLK		4	11.5	4	9	113
<sup>t</sup> PZH	⊼e.	_	2	7	2	6	ns
tPZL	ŌĒ	Q	3	11	3	10	113
<sup>t</sup> PHZ	ŌĒ .	a	2	10	2	6	ns
tPLZ	JE .	L	2	7	2	6	113

<sup>\*</sup> On products compliant to MIL-STD-883, Class B, this parameter is based on characterization data but is not production tested.

The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

<sup>9</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

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#### **APPLICATION INFORMATION**

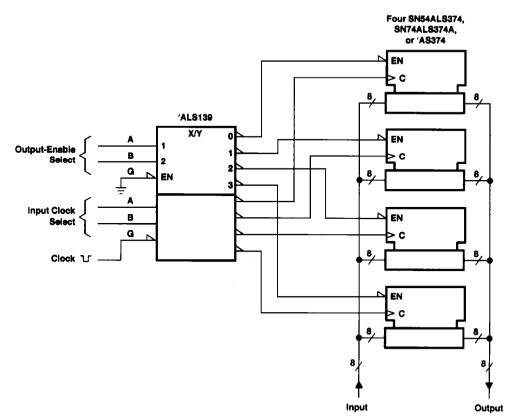


Figure 1. Expandable 4-Word by 8-Bit General File Register

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### **APPLICATION INFORMATION**

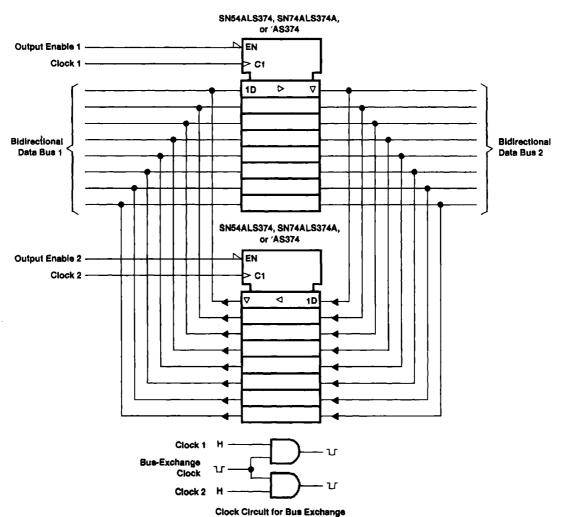
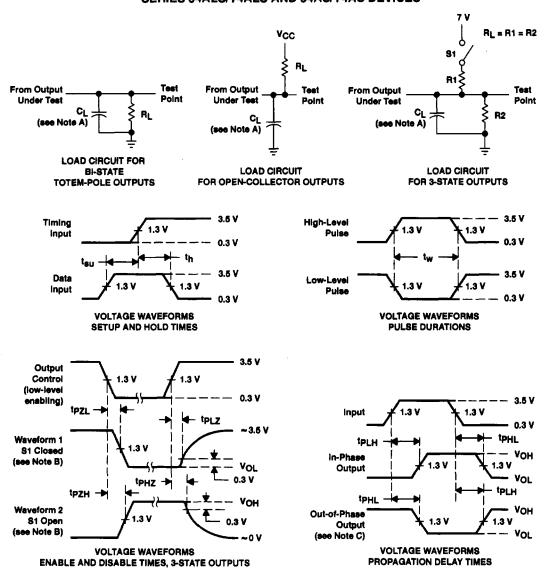


Figure 2. Bidirectional Bus Driver

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#### PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- D. All input pulses have the following characteristics: PRR  $\leq$  1 MHz,  $t_r = t_f = 2$  ns, duty cycle = 50%.
- E. The outputs are measured one at a time with one transition per measurement.

Figure 3. Load Circuits and Voltage Waveforms

